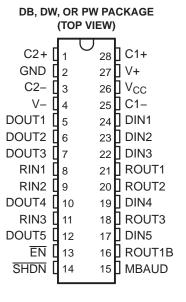


3-V TO 5.5-V MULTICHANNEL RS-232 1-MBit/s LINE DRIVER/RECEIVER

Check for Samples: TRS3237E

FEATURES

- Meets or Exceeds the Requirements of TIA/EIA-232-F and ITU v.28 Standards
- Operates With 3-V to 5.5-V V_{CC} Supply
- Operates From 250 kbits/s to 1 Mbit/s
- Low Standby Current . . . 1 μA Typical
- External Capacitors . . . 4 × 0.1 μF
- Accepts 5-V Logic Input With 3.3-V Supply
- Designed to Be Interchangeable With Industry Standard '3237E Devices
- Latch-Up Performance Exceeds 100 mA Per JESD 78, Class II

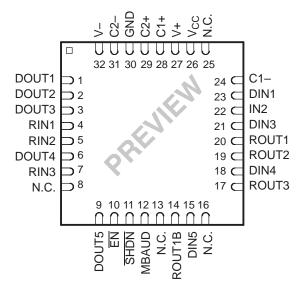


- ESD Protection for RS-232 I/O Pins
 - ±15 kV Human-Body Model (HBM)
 - ±8 kV IEC61000-4-2, Contact Discharge
 - ±15 kV IEC61000-4-2, Air-Gap Discharge

APPLICATIONS

- Battery-Powered, Hand-Held, and Portable Equipment
- PDAs and Palmtop PCs
- Notebooks, Sub-Notebooks, and Laptops
- Digital Cameras
- Mobile Phones and Wireless Devices

RHB PACKAGE (TOP VIEW)



N.C.- Not internally connected

DESCRIPTION/ORDERING INFORMATION

The TRS3237E consists of five line drivers, three line receivers, and a dual charge-pump circuit with ± 15 -kV ESD protection pin to pin (serial-port connection pins, including GND). The device meets the requirements of TIA/EIA-232-F and provides the electrical interface between an asynchronous communication controller and the serial-port connector. The charge pump and four small external capacitors allow operation from a single 3-V to 5.5-V supply. This device operates at data signaling rates of 250 kbit/s in normal operating mode (MBAUD = GND) and 1Mbit/s when MBAUD = V_{CC} . The driver output slew rate is a maximum of 30 V/ μ s.



Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.



The TRS3237E transmitters are disabled and the outputs are forced into high-impedance state when the device is in shutdown mode (SHDN = GND) and the supply current falls to less than 1 μ A. Also, during shutdown, the onboard charge pump is disabled; V+ is lowered to V_{CC}, and V- is raised toward GND. Receiver outputs also can be placed in the high-impedance state by setting enable (EN) high. ROUT1B remains active all the time, regardless of the EN and SHDN condition.

The TRS3237EC is characterized for operation from 0°C to 70°C. The TRS3237EI is characterized for operation from –40°C to 85°C.

Table 1. ORDERING INFORMATION(1)

T _A	P	ACKAGE ⁽²⁾	ORDERABLE PART NUMBER	TOP-SIDE MARKING
	SSOP – DB	Reel of 2000	TRS3237ECDBR	TRS3237EC
0°C to 70°C	SOIC - DW	Reel of 2000	TRS3237ECDWR	TRS3237EC
0°C to 70°C	TSSOP - PW	Reel of 2000	TRS3237ECPWR	RS37EC
	QFN – RHB	Reel of 2000	TRS3237ECRHBR	PREVIEW
	SSOP – DB	Reel of 2000	TRS3237EIDBR	TRS3237EI
4000 +- 0500	SOIC - DW	Reel of 2000	TRS3237EIDWR	TRS3237EI
–40°C to 85°C	TSSOP – PW	Reel of 2000	TRS3237EIPWR	RS37EI
	QFN – RHB	Reel of 2000	TRS3237EIRHBR	PREVIEW

⁽¹⁾ For the most current package and ordering information, see the Package Option Addendum at the end of this document, or see the TI web site at www.ti.com.

Table 2. FUNCTION TABLE

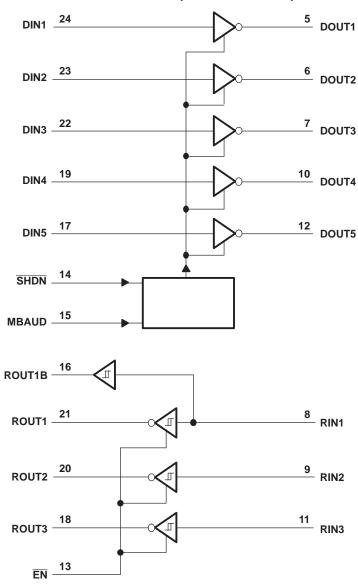
INPUT	S		OUTPUTS	
SHDN	EN	DOUT	ROUT	ROUT1B
0	0	Z ⁽¹⁾	Active	Active
0	1	Z ⁽¹⁾	Z ⁽¹⁾	Active
1	0	Active	Active	Active
1	1	Active	Z ⁽¹⁾	Active

(1) Z = high impedance (off)

⁽²⁾ Package drawings, thermal data, and symbolization are available at www.ti.com/packaging.



LOGIC DIAGRAM (POSITIVE LOGIC)





ABSOLUTE MAXIMUM RATINGS(1)

over operating free-air temperature range (unless otherwise noted)

			MIN	MAX	UNIT
V _{CC}	Supply voltage range (2)		-0.3	6	V
V+	Positive-output supply voltage range (2)		-0.3	7	V
V-	legative-output supply voltage range ⁽²⁾		0.3	-7	V
V+ - V-	Supply voltage difference ⁽²⁾			13	V
	Innut valtage ronge	Driver (SHDN, MBAUD, EN)	-0.3	6	V
VI	Input voltage range	Receiver	-25	25	V
	Output valtage range	Driver	-13.2	13.2	
Vo	Output voltage range	Receiver	-0.3	V _{CC} + 0.3	V
	Short-circuit duration	DOUT to GND	Unlin	nited	
θ_{JA}	Package thermal impedance ⁽³⁾			62	°C/W
T _{stg}	Storage temperature range		-65	150	°C

⁽¹⁾ Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

RECOMMENDED OPERATING CONDITIONS(1)

See Figure 5

				MIN	NOM	MAX	UNIT
	Cumply yeltogo		V _{CC} = 3.3 V	3	3.3	3.6	\/
	Supply voltage		$V_{CC} = 5 V$	4.5	5	5.5	V
.,	Driver and control binb level input value	DIN, SHDN, MBAUD, EN	V _{CC} = 3.3 V	2		5.5	
V_{IH}	Driver and control high-level input voltage	DIN, SHDN, MBAUD, EN	V _{CC} = 5 V	2.4		5.5	V
V _{IL}	Driver and control low-level input voltage	DIN, SHDN, MBAUD, EN		0		0.8	V
VI	Receiver input voltage			-25		25	V
_			TRS3237EC	0		70	۰,
T _A	Operating free-air temperature		TRS3237EI	-40		85	°C

⁽¹⁾ Test conditions are C1–C4 = 0.1 μ F at V_{CC} = 3 V to 5 V.

ELECTRICAL CHARACTERISTICS(1)

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted) (see Figure 5)

	PARAME	TEST CONDITIONS	MIN TYP ⁽²⁾	MAX	UNIT	
II	Input leakage current	DIN, SHDN, MBAUD, EN		9	18	μА
			No load, SHDN = V _{CC}	0.5	2	mA
loo	Supply current		SHDN = GND	1	10	μА
ICC	(T _A = 25°C)	Shutdown supply current	SHDN = RIN = GND, DIN = GND or V _{CC}	10	300	nA

All voltages are with respect to network GND.

⁽³⁾ The package thermal impedance is calculated in accordance with JESD 51-7.

Test conditions are C1–C4 = 0.1 μ F at V_{CC} = 3 V to 5 V. All typical values are at V_{CC} = 3.3 V or V_{CC} = 5 V, and T_A = 25°C.



DRIVER SECTION ELECTRICAL CHARACTERISTICS(1)

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted) (see Figure 5)

PARAMETER		TEST CONDITIONS			TYP ⁽²⁾	MAX	UNIT
V_{OH}	High-level output voltage	DOUT at $R_L = 3 \text{ k}\Omega$ to GND,	DIN = GND	5	5.4		V
V _{OL}	Low-level output voltage	DOUT at $R_L = 3 \text{ k}\Omega$ to GND,	DIN = V _{CC}	-5	-5.4		V
I_{IH}	High-level input current	$V_I = V_{CC}$			±0.01	±1	μΑ
$I_{\parallel L}$	Low-level input current	V _I at GND			±0.01	±1	μΑ
Ios	Short-circuit output current (3)	$V_{CC} = 3.6 \text{ V or } 3.3 \text{ V},$	$V_O = 0 V$			±60	mA
r _o	Output resistance	V_{CC} , V_+ , and $V = 0 V$,	$V_O = \pm 2 V$	300	50k		Ω

DRIVER SECTION SWITCHING CHARACTERISTICS(1)

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted) (see Figure 5)

	PARAMETER	TE	ST CONDITIONS		MIN	TYP ⁽²⁾	MAX	UNIT
		C _L = 1000 pF, MBAUD = GND			250			
	Maximum data rate	$\begin{split} &C_L = 1000 \text{ pF}, \\ &V_{CC} = 4.5 \text{ V to } 5.5 \text{ V}, \\ &MBAUD = V_{CC} \end{split}$	$R_L = 3 \text{ k}\Omega$, 1 DIN switching, See Figure 1		1000			kbit/s
		$C_L = 250 \text{ pF},$ $V_{CC} = 3 \text{ V to } 4.5 \text{ V},$ $MBAUD = V_{CC}$		1000				
t _{sk(p)}	Pulse skew ⁽³⁾	C_L = 150 pF to 2500 pF, R_l MBAUD = V_{CC} or GND, Se				100		ns
	Slew rate,	V _{CC} = 3.3 V,	C _L = 150 pF to 1000 pF	MBAUD = GND	6		30	
SR(tr)	transition region	,		$MBAUD = V_{CC}$	24		150	V/μs
	(see Figure 1)	T _A = 25°C	C _L = 150 pF to 2500 pF,	MBAUD = GND	4		30	

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 ⁽¹⁾ Test conditions are C1–C4 = 0.1 μF at V_{CC} = 3 V to 5 V.
 (2) All typical values are at V_{CC} = 3.3 V or V_{CC} = 5 V, and T_A = 25°C.
 (3) Short-circuit durations should be controlled to prevent exceeding the device absolute power-dissipation ratings, and not more than one output should be shorted at a time.

⁽²⁾

Test conditions are C1–C4 = 0.1 μ F at V_{CC} = 3 V to 5 V. All typical values are at V_{CC} = 3.3 V or V_{CC} = 5 V, and T_A = 25°C. Pulse skew is defined as $|t_{PLH}-t_{PHL}|$ of each channel of the same device.



RECEIVER SECTION ELECTRICAL CHARACTERISTICS(1)

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted) (see Figure 5)

	PARAMETER	TEST CONDITIONS	MIN	TYP ⁽²⁾	MAX	UNIT
V_{OH}	High-level output voltage	$I_{OH} = -1 \text{ mA}$	$V_{CC} - 0.6$	$V_{CC} - 0.1$		V
V_{OL}	Low-level output voltage	$I_{OL} = 1 \text{ mA}$			0.4	V
\/	Desitive going input threshold voltage	$V_{CC} = 3.3 \text{ V}$		1.5	2.4	V
V _{IT+}	Positive-going input threshold voltage	$V_{CC} = 5 V$		2	2.4	V
\/	No gotivo going input throughold voltage	$V_{CC} = 3.3 \text{ V}$	0.6	1.1		V
V_{IT-}	Negative-going input threshold voltage	$V_{CC} = 5 V$	0.8	1.5		V
V_{hys}	Input hysteresis (V _{IT+} - V _{IT-})			0.5		V
l _{oz}	Output leakage current	$\overline{EN} = V_{CC}$		±0.05	±10	μΑ
ri	Input resistance	$V_I = \pm 3 \text{ V to } \pm 25 \text{ V}$	3	5	7	kΩ

RECEIVER SECTION SWITCHING CHARACTERISTICS(1)

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

	PARAMETER	TEST CONDITIONS	TYP ⁽²⁾	UNIT
t _{PLH}	Propagation delay time, low- to high-level output	C _L = 150 pF, See Figure 3	150	ns
t _{PHL}	Propagation delay time, high- to low-level output	C _L = 150 pF, See Figure 3	150	ns
t _{en}	Output enable time	$C_L = 150 \text{ pF}, R_L = 3 \text{ k}\Omega, \text{ See Figure 4}$	2.6	μS
t _{dis}	Output disable time	$C_L = 150 \text{ pF}, R_L = 3 \text{ k}\Omega, \text{ See Figure 4}$	2.4	μS
t _{sk(p)}	Pulse skew ⁽³⁾	See Figure 3	50	ns

ESD PROTECTION

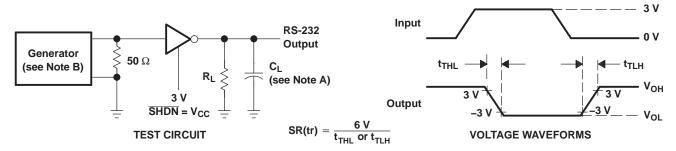
PIN	TEST CONDITIONS	TYP	UNIT	
DOLLT DIN	IEC61000-4-2, Contact Discharge	±8	kV	
DOUT, RIN	IEC61000-4-2, Air-Gap Discharge		ΚV	

⁽¹⁾ Test conditions are C1–C4 = 0.1 mF at V_{CC} = 3 V to.5 V. (2) All typical values are at V_{CC} = 3.3 V or V_{CC} = 5 V, and T_A = 25°C.

Test conditions are C1–C4 = 0.1 μ F at V_{CC} = 3 V to 5 V. All typical values are at V_{CC} = 3.3 V or V_{CC} = 5 V, and T_A = 25°C. Pulse skew is defined as $|t_{PLH}-t_{PHL}|$ of each channel of the same device.



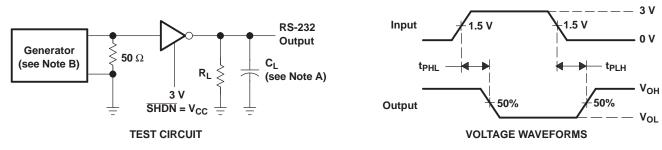
PARAMETER MEASUREMENT INFORMATION



NOTES: A. C_L includes probe and jig capacitance.

B. The pulse generator has the following characteristics: PRR = 250 kbit/s, $Z_O = 50 \Omega$, 50% duty cycle, $t_r \le 10$ ns. $t_f \le 10$ ns.

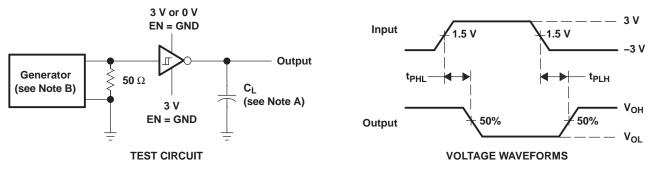
Figure 1. Driver Slew Rate



NOTES: A. C_L includes probe and jig capacitance.

B. The pulse generator has the following characteristics: PRR = 250 kbit/s, $Z_O = 50 \Omega$, 50% duty cycle, $t_r \le 10$ ns. $t_f \le 10$ ns.

Figure 2. Driver Pulse Skew



NOTES: A. C_L includes probe and jig capacitance.

B. The pulse generator has the following characteristics: $Z_O = 50 \Omega$, 50% duty cycle, $t_r \le 10$ ns. $t_f \le 10$ ns.

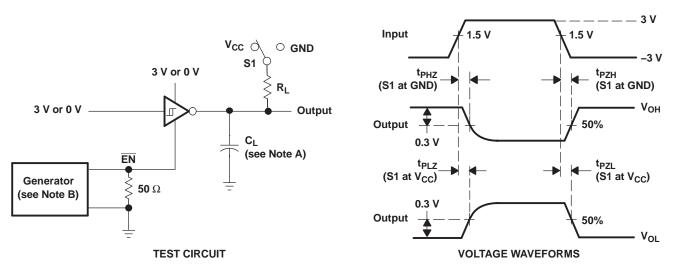
Figure 3. Receiver Propagation Delay Times

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Product Folder Link(s): TRS3237E



PARAMETER MEASUREMENT INFORMATION (continued)



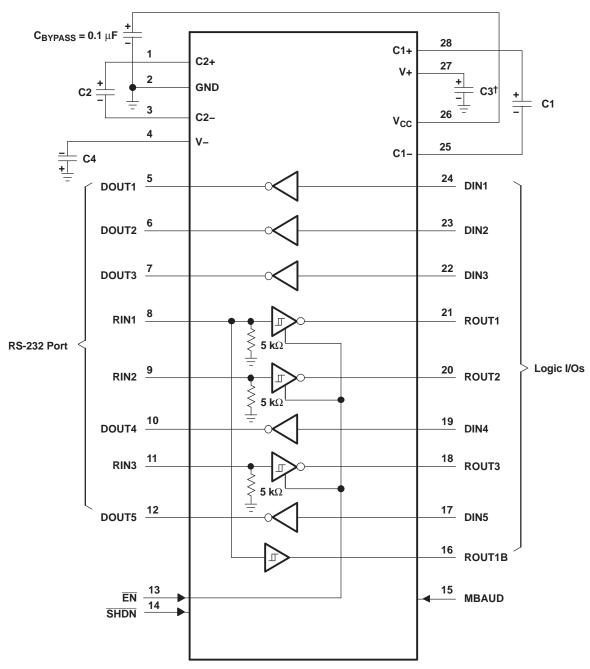
NOTES: A. C_L includes probe and jig capacitance.

- B. The pulse generator has the following characteristics: $Z_0 = 50 \ \Omega$, 50% duty cycle, $t_r \le 10 \ ns$, $t_f \le 10 \ ns$.
- C. t_{PLZ} and t_{PHZ} are the same as t_{dis} .
- D. t_{PZL} and t_{PZH} are the same as t_{en}.

Figure 4. Receiver Enable and Disable Times



APPLICATION INFORMATION



 $^{^{\}dagger}$ C3 can be connected to V_{CC} or GND.

NOTES: A. Resistor values shown are nominal.

B. Nonpolarized ceramic capacitors are acceptable. If polarized tantalum or electrolytic capacitors are used, they should be connected as shown.

V_{CC} vs CAPACITOR VALUES

V _{CC}	C1	C2, C3, and C4
$ \begin{array}{c} \textbf{3.3 V} \pm \textbf{0.15 V} \\ \textbf{3.3 V} \pm \textbf{0.3 V} \\ \textbf{5 V} \pm \textbf{0.5 V} \\ \textbf{3 V to 5.5 V} \\ \end{array} $	0.1 μF 0.22 μF 0.047 μF 0.22 μF	0.1 μF 0.22 μF 0.33 μF 1 μF

Figure 5. Typical Operating Circuit and Capacitor Values

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PACKAGING INFORMATION

Orderable part number	Status	Material type	Package Pins	Package qty Carrier	RoHS	Lead finish/	MSL rating/	Op temp (°C)	Part marking
	(1)	(2)			(3)	Ball material	Peak reflow		(6)
						(4)	(5)		
TRS3237ECDBR	Active	Production	SSOP (DB) 28	2000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	0 to 70	TRS3237EC
TRS3237ECDBR.A	Active	Production	SSOP (DB) 28	2000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	TRS3237EC
TRS3237ECPWR	Obsolete	Production	TSSOP (PW) 28	-	-	Call TI	Call TI	0 to 70	RS37EC
TRS3237EIDB	Obsolete	Production	SSOP (DB) 28	-	-	Call TI	Call TI	-40 to 85	TRS3237EI
TRS3237EIDBR	Active	Production	SSOP (DB) 28	2000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	TRS3237EI
TRS3237EIDBR.A	Active	Production	SSOP (DB) 28	2000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	TRS3237EI
TRS3237EIDBRG4	Active	Production	SSOP (DB) 28	2000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	TRS3237EI
TRS3237EIDBRG4.A	Active	Production	SSOP (DB) 28	2000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	TRS3237EI
TRS3237EIPWR	Active	Production	TSSOP (PW) 28	2000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	RS37EI
TRS3237EIPWR.A	Active	Production	TSSOP (PW) 28	2000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	RS37EI

⁽¹⁾ Status: For more details on status, see our product life cycle.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

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⁽²⁾ Material type: When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

⁽³⁾ RoHS values: Yes, No, RoHS Exempt. See the TI RoHS Statement for additional information and value definition.

⁽⁴⁾ Lead finish/Ball material: Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

⁽⁵⁾ **MSL rating/Peak reflow:** The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

⁽⁶⁾ Part marking: There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.



PACKAGE OPTION ADDENDUM

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and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

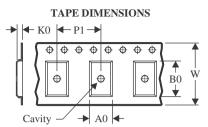
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PACKAGE MATERIALS INFORMATION

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TAPE AND REEL INFORMATION





A0	Dimension designed to accommodate the component width
В0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal

Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
TRS3237ECDBR	SSOP	DB	28	2000	330.0	16.4	8.2	10.5	2.5	12.0	16.0	Q1
TRS3237EIDBR	SSOP	DB	28	2000	330.0	16.4	8.2	10.5	2.5	12.0	16.0	Q1
TRS3237EIDBRG4	SSOP	DB	28	2000	330.0	16.4	8.2	10.5	2.5	12.0	16.0	Q1
TRS3237EIPWR	TSSOP	PW	28	2000	330.0	16.4	6.9	10.2	1.8	12.0	16.0	Q1



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*All dimensions are nominal

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Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
TRS3237ECDBR	SSOP	DB	28	2000	356.0	356.0	35.0
TRS3237EIDBR	SSOP	DB	28	2000	356.0	356.0	35.0
TRS3237EIDBRG4	SSOP	DB	28	2000	356.0	356.0	35.0
TRS3237EIPWR	TSSOP	PW	28	2000	356.0	356.0	35.0

PW (R-PDSO-G28)

PLASTIC SMALL OUTLINE



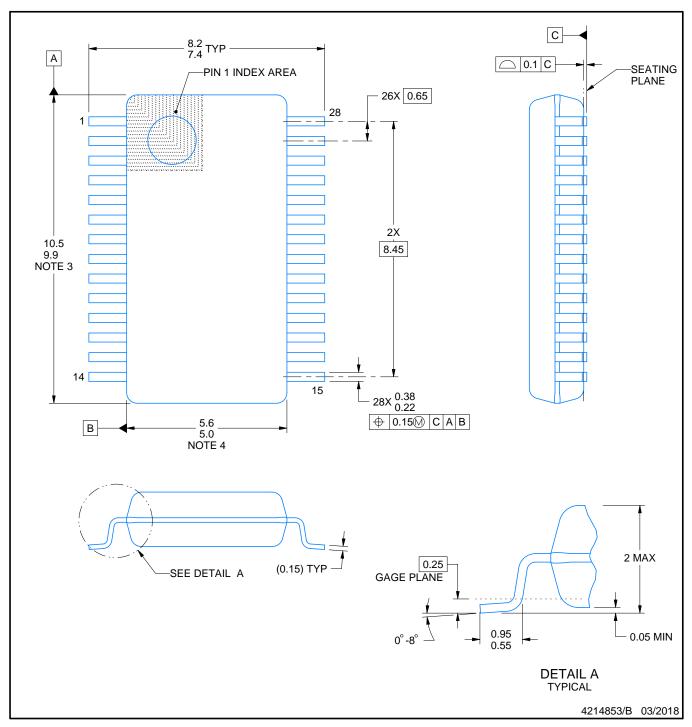
NOTES:

- A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M—1994.
- B. This drawing is subject to change without notice.
- Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0,15 each side.
- Body width does not include interlead flash. Interlead flash shall not exceed 0,25 each side.
- E. Falls within JEDEC MO-153





SMALL OUTLINE PACKAGE



NOTES:

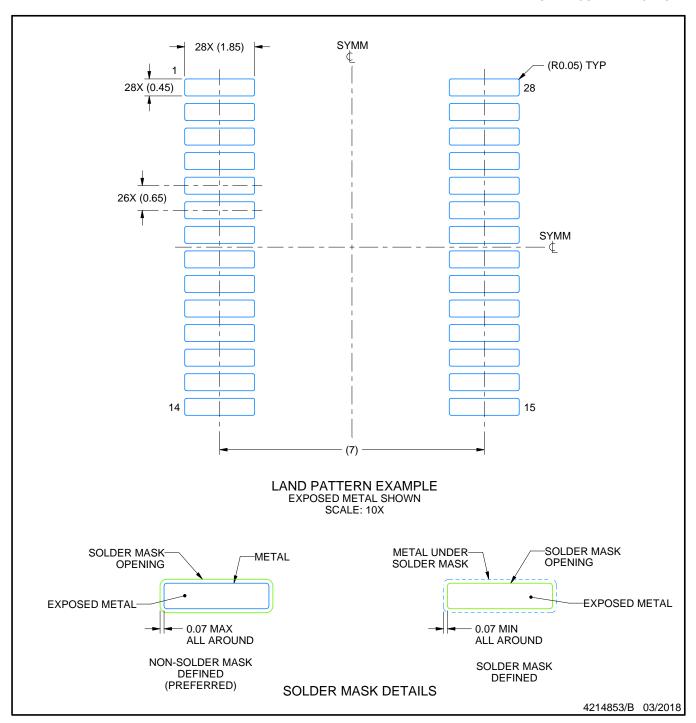
- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

 2. This drawing is subject to change without notice.

 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
- 5. Reference JEDEC registration MO-150.



SMALL OUTLINE PACKAGE



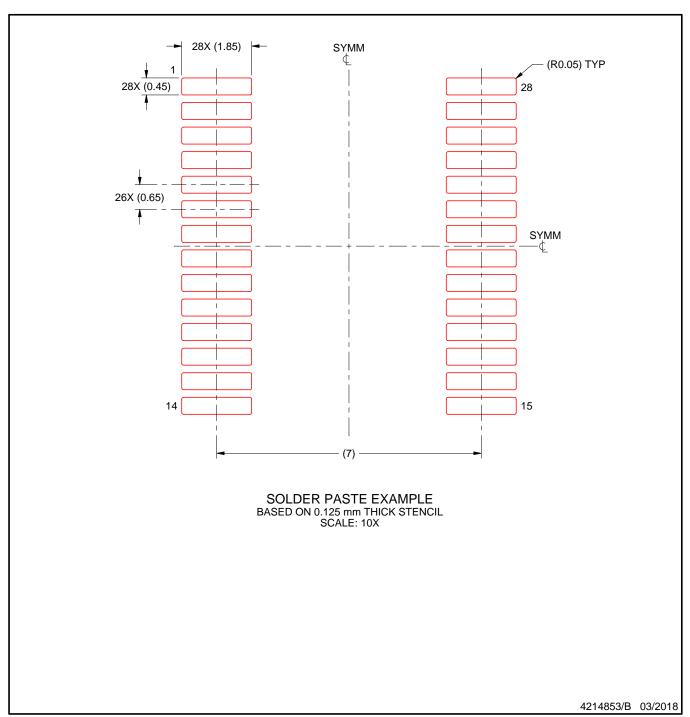
NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



SMALL OUTLINE PACKAGE



NOTES: (continued)

- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.



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